

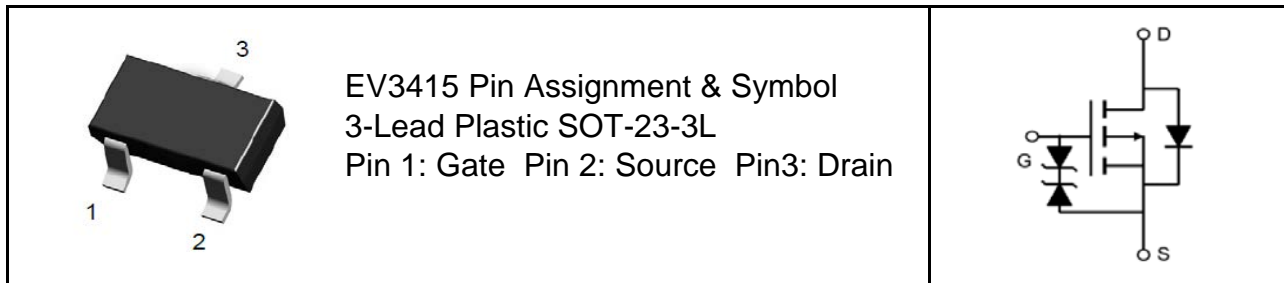
### P-Channel Enhancement-Mode MOSFET (-20V, -4.0A)

#### PRODUCT SUMMARY

$V_{DSS}$	$I_D$	$R_{DS(on)}$ (m $\Omega$ ) Typ.
-20V	-4.0A	28 @ $V_{GS} = -4.5V, I_D = -4A$
		33 @ $V_{GS} = -2.5V, I_D = -4A$
		38 @ $V_{GS} = -1.5V, I_D = -2A$

#### Features

- Super high dense cell trench design for low  $R_{DS(on)}$
- Rugged and reliable
- SOT-23-3L package
- ESD
- Lead (Pb) -free and halogen-free



#### Absolute Maximum Ratings ( $T_A = 25^\circ\text{C}$ , unless otherwise noted)

Symbol	Parameter	Ratings	Units
$V_{DS}$	Drain-Source Voltage	-20	V
$V_{GS}$	Gate-Source Voltage	$\pm 8$	V
$I_D$	Drain Current (Continuous)	-4	A
$I_{DM}$	Drain Current (Pulsed) <sup>a</sup>	-30	A
$P_D$	Total Power Dissipation @ $T_A = 25^\circ\text{C}$	1.4	W
$I_S$	Maximum Diode Forward Current	2	A
$T_j, T_{stg}$	Operating Junction and Storage Temperature Range	-55 to +150	$^\circ\text{C}$
$R_{QJA}$	Thermal Resistance Junction to Ambient (PCB mounted) <sup>b</sup>	100	$^\circ\text{C/W}$

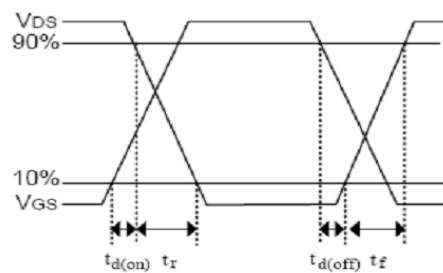
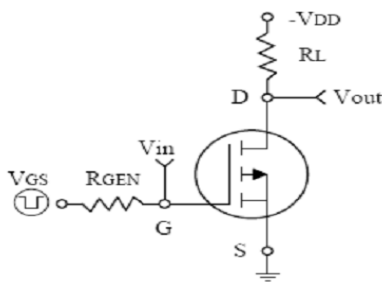
a: Repetitive Rating: Pulse width limited by the maximum junction temperature.

b: 1-in<sup>2</sup> 2oz Cu PCB board

### Electrical Characteristics ( $T_A=25^\circ\text{C}$ , unless otherwise noted)

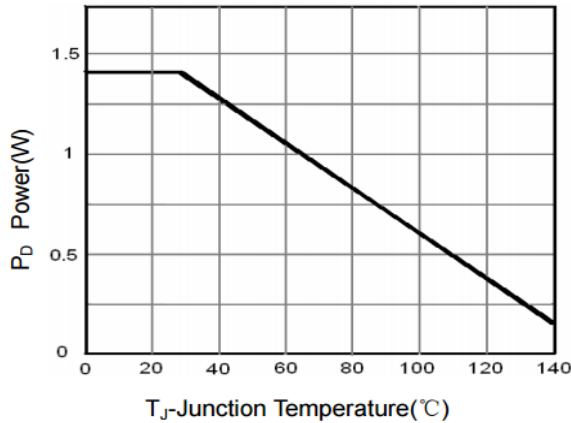
Symbol	Characteristic	Test Conditions	Min.	Typ.	Max.	Unit
<b>• Off Characteristics</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=-250\mu A$	-20	-	-	V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS}=-20V, V_{GS}=0V$	-	-	1	$\mu A$
$I_{GSS}$	Gate-Body Leakage Current	$V_{GS}=\pm 8V, V_{DS}=0V$	-	-	$\pm 10$	$\mu A$
<b>• On Characteristics</b>						
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=-250\mu A$	-0.45	-0.55	-1	V
$R_{DS(on)}$	Drain-Source On-State Resistance	$V_{GS}=-4.5V, I_D=-4A$	-	28	34	m $\Omega$
		$V_{GS}=-2.5V, I_D=-4A$	-	33	40	
		$V_{GS}=-1.8V, I_D=-2A$	-	38	46	
<b>• Dynamic Characteristics</b>						
$C_{iss}$	Input Capacitance	$V_{DS}=-10V, V_{GS}=0V, f=1\text{MHz}$	-	950	-	PF
$C_{oss}$	Output Capacitance		-	165	-	
$C_{rss}$	Reverse Transfer Capacitance		-	120	-	
<b>• Switching Characteristics</b>						
$Q_g$	Total Gate Charge	$V_{DS}=-10V, I_D=-1A, V_{GS}=-4.5V$	-	12	-	nC
$Q_{gs}$	Gate-Source Charge		-	10	-	
$Q_{gd}$	Gate-Drain Charge		-	19	-	
$t_{d(on)}$	Turn-on Delay Time	$V_{DD}=-10V, R_L=15\Omega, I_D=1A, V_{GEN}=-4.5V, R_G=10\Omega$	-	12	-	nS
$t_r$	Turn-on Rise Time		-	10	-	
$t_{d(off)}$	Turn-off Delay Time		-	19	-	
$t_f$	Turn-off Fall Time		-	25	-	
<b>• Drain-Source Diode Characteristics</b>						
$V_{SD}$	Drain-Source Diode Forward	$V_{GS}=0V, I_S=-1A$	-	-	-1	V

Note: Pulse Test: Pulse Width  $\leq 300\mu s$ , Duty Cycle  $\leq 2\%$

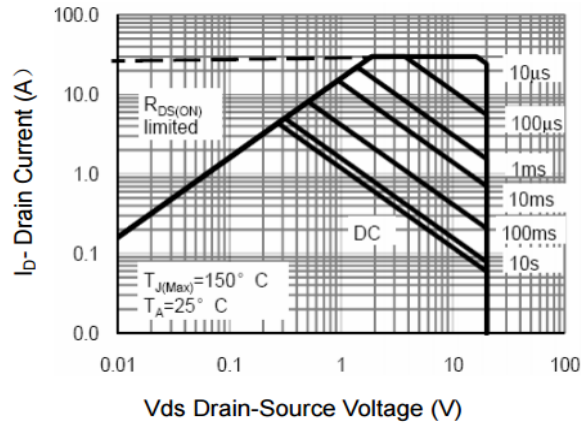


Switching Test Circuit and Switching Waveforms

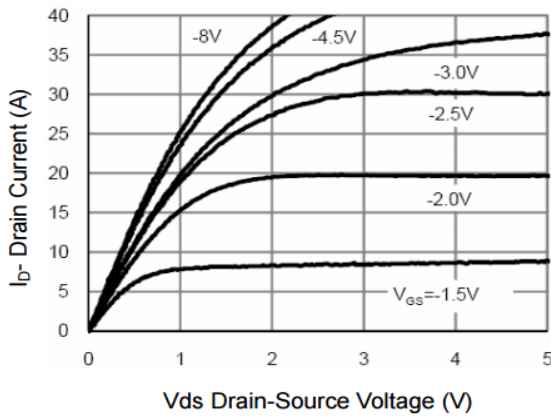
### Typical Characteristics Curves ( $T_a=25^\circ\text{C}$ , unless otherwise note)



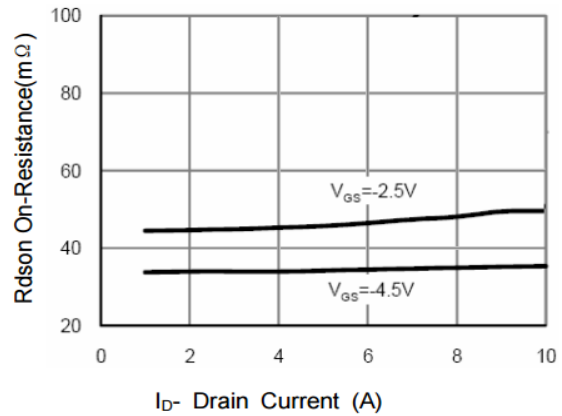
**Figure 1 Power Dissipation**



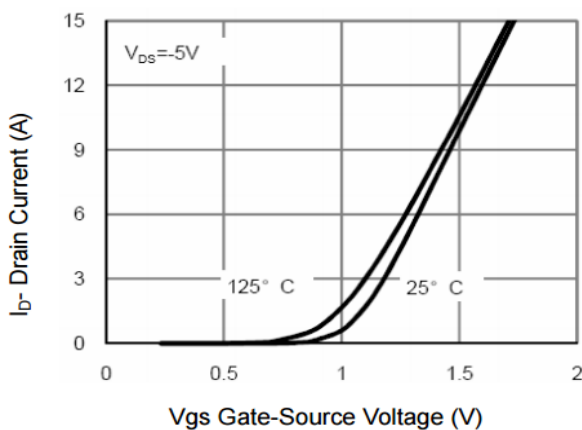
**Figure 2 Safe Operation Area**



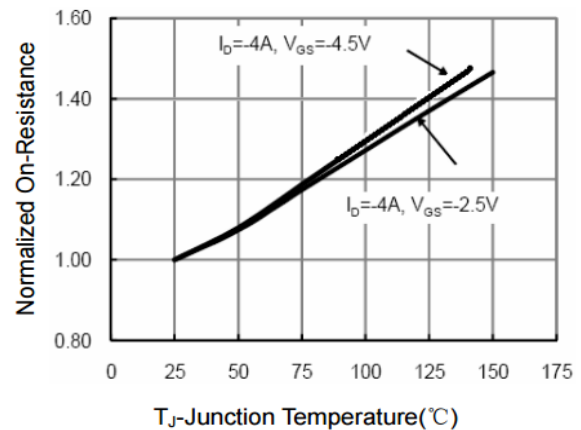
**Figure 3 Output Characteristics**



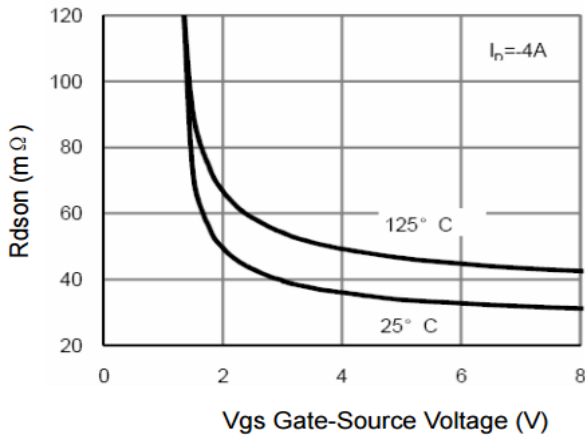
**Figure 4 Drain-Source On-Resistance**



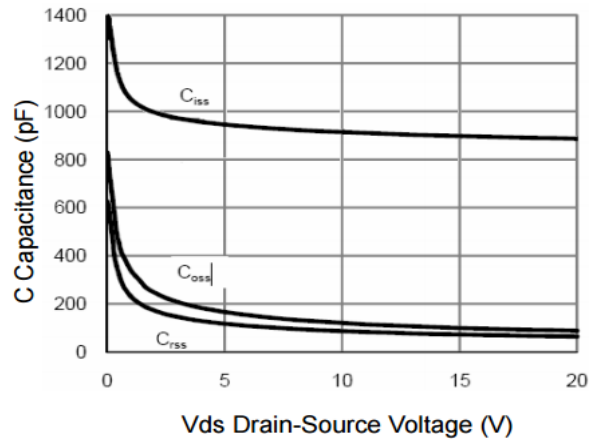
**Figure 5 Transfer Characteristics**



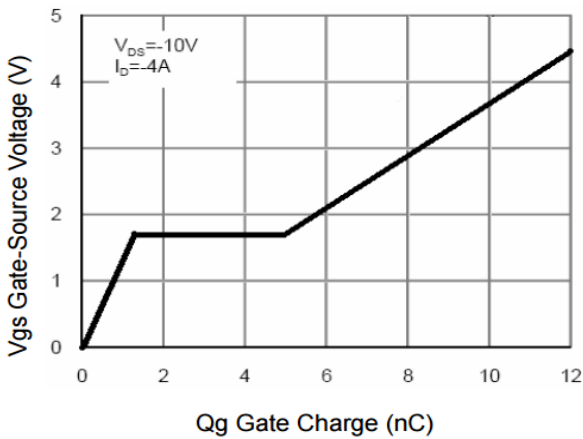
**Figure 6 Drain-Source On-Resistance**



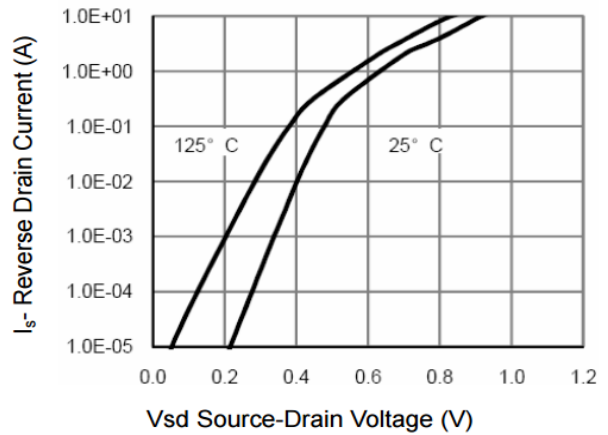
**Figure 7 Rdson vs Vgs**



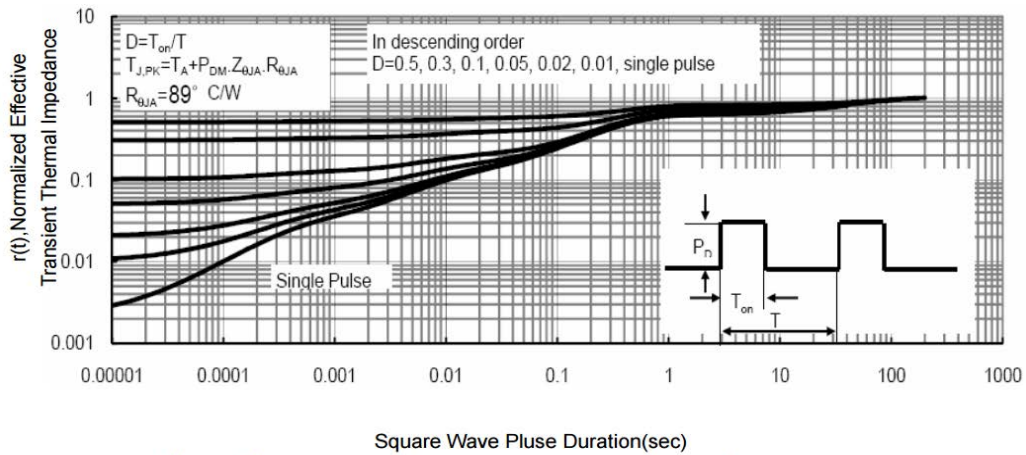
**Figure 8 Capacitance vs Vds**



**Figure 9 Gate Charge**

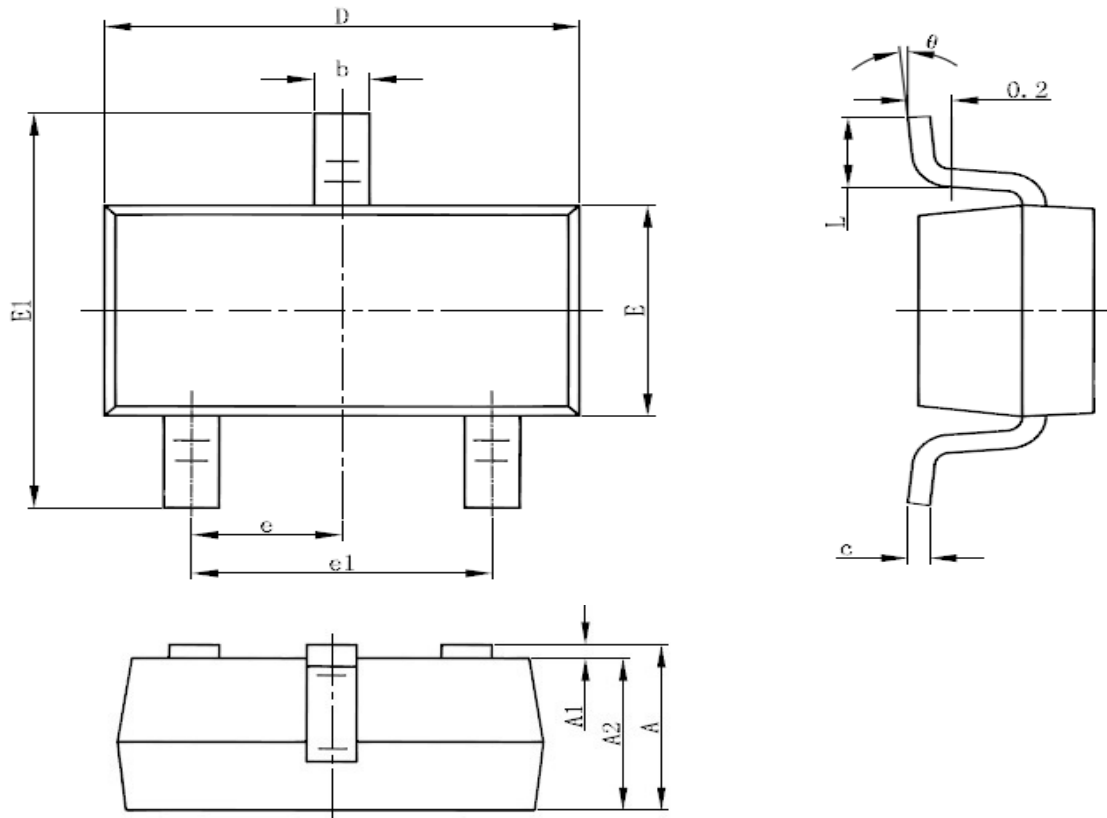


**Figure 10 Source-Drain Diode Forward**



**Figure 11 Normalized Maximum Transient Thermal Impedance**

### SOT23-3L PACKAGE OUTLINE DIMENSIONS



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	0.850	1.250	0.033	0.049
A1	0.000	0.100	0.000	0.004
A2	0.7	1.150	0.028	0.045
b	0.300	0.500	0.012	0.020
c	0.100	0.200	0.004	0.008
D	2.820	3.020	0.111	0.119
E	1.500	1.700	0.059	0.067
E1	2.650	2.950	0.104	0.116
e	0.950(BSC)		0.037(BSC)	
e1	1.800	2.000	0.071	0.079
L	0.300	0.600	0.012	0.024
$\theta$	0°	8°	0°	8°